Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO. 252192US2		SERIAL NO. New Application		
(Modified)		PATENT AND TRAC	EMARK OFFICE					
				APPLICANT				
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Minoru TAKAYA, et al.				
				FILING DATE		GROUP		
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U.S. PATENT DOCUMENTS								
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB FILING DATE		
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FOREIGN PATENT DOCUMENTS								
	DOCUMENT DATE COUNTRY					TRANSLATION		
		NUMBER	DATE	DATE COUNTRY		YES NO		
AG	AO	5-267063	10/15/93	Japan (with English Abstract)				х
AG	AP	2002-324729	11/08/02	Japan (with English Abstract)				x
AG	AQ	7-22251	01/24/95	Japan (with English Abstract)				×
AG	AR	8-216313	08/27/96	Japan (with English Abstract)				x .
AG	AS	5-48271	02/26/93	Japan (with English Abstract)	•			x
AG	AT	4-84489	03/17/92	Japan (with English Abstract)				×
AG	AU	3-147205	06/24/91	Japan (with English Abstract)				×
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
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	AZ	Additional References sheet(s) attached						
Examiner		Anna Gofman/			Date Considered 04/11/2006			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								